00862.023119

PATENT APPLICATION

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

| In re Application of: |) | |
|-------------------------------|---|----------------------|
| | : | Examiner: A. Dudding |
| TETSUHITO IKEDA, ET AL. |) | |
| | : | Group Art Unit: 2853 |
| Appln. No.: 10/614,012 |) | |
| | : | |
| Filed: July 8, 2003 |) | |
| | : | |
| For: LIQUID DETECTION METHOD, |) | |
| LIQUID DETECTION APPARATUS | : | |
| AND PRINTING APPARATUS |) | |
| USING THE LIQUID DETECTION |) | June 2, 2005 |

Mail Stop Amendment Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

SUPPLEMENTAL INFORMATION DISCLOSURE STATEMENT

Sir:

Further to the Information Disclosure Statement filed October 27, 2003, in compliance with the duty of disclosure under 37 CFR 1.56 and in accordance with the practice under 37 CFR 1.97 and 1.98, the Examiner's attention is directed to the documents listed on the enclosed Form PTO-1449. Copies of the listed documents are also enclosed.

The listed documents were cited in an Office Action of a corresponding

Japanese application. A copy of the Office Action is included for the Examiner's

convenience.

JP '220, JP '219, JP '677 and JP '961 may be relevant for the reasons

summarized in their respective English abstracts.

It is respectfully requested that the above information be considered by the

Examiner and that a copy of the enclosed Form PTO-1449 be returned indicating that such

information has been considered.

STATEMENT UNDER 37 CFR 1.97(e)

Each item of information in this information disclosure statement was first

cited in any communication from a foreign Patent Office in a counterpart foreign

application not more than three months prior to the filing date of this Statement.

Applicants' undersigned attorney may be reached in our Washington, D.C.

office by telephone at (202) 530-1010. All correspondence should continue to be directed

to our address given below.

Respectfully submitted,

Mark A. Williamson

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| Sheet 1 of 1 | | | | | - | | | | | | |
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| FORM PTO 1449 (modified) | | | ATTY. DOCKET NO. APPLI 00862.023119 | | | LICATION NO. 10/614,012 | | | | | |
| U.S. (PATE | APPLICANTS | | | | | | | | | | |
| LIST OF REFERENCES CITED BY APPLICANT(S) TETSUHITO IKEDA, ET AL. | | | | | | | | | | | |
| (Use several sheets if necessary) Date Submitted to PTO: June 2, 2005 | | | CFILING DATE July 8, 2003 | | | GROUP | | | | | |
| | | | <u> </u> | July 8, 2003 | | 2853 | | | | | |
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| *EXAMINER'S INITIAL | <u> </u> | DOCUMENT NUMBER | - WAILE | IN | AME | CLASS | SUBCLASS | FILING DATE IF APPROPRIATE | | | |
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| FOREIGN PATENT DOCUMENTS | | | | | | | | | | | |
| | [| DOCUMENT NUMBER | DATE | | JNTRY | CLASS | SUBCLASS | TRANSLATION YES/NO/ OR ABSTRACT | | | |
| | 20 | 00-289220 | 10/2000 | JAPAN | | | | ABSTRACT | | | |
| | 20 | 00-351219 | 12/2000 | JAPAN | | | | ABSTRACT | | | |
| | 20 | 01-113677 | 04/2001 | JAPAN | | | | ABSTRACT | | | |
| | 20 | 02-001961 | 01/2002 | JAPAN | | | | ABSTRACT | | | |
| | | | | | | | | | | | |
| OTHER DOCUMENT(S) (Including Author, Title, Date, Pertinent Pages, Etc.) | | | | | | | | | | | |
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| EXAMINER DATE CONSIDERED | | | | | | | | | | | |

^{*}EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to Applicant.